TriQuint () SEMICONDUCTOR®

**Advance Product Information** 

October 20, 2004

# 6.5 Watt Ku Band Power Amplifier

TGA2514- EPU-FL



## **Product Description**

The TGA2514-EPU-FL provides 24 dB of gain and 6.5W of output power across 13-16 GHz. The TGA2514-EPU-FL is designed using TriQuint's proven standard 0.25-µm gate pHEMT production process.

This device is ideally suited for VSAT Transmitter and Point to Point Radio applications. The flange lead package has a high thermal conductivity copper alloy base.

Evaluation Boards are available.

## **Key Features**

- Frequency Range: 13 16 GHz
- 38 dBm Nominal Psat
- 24 dB Nominal Gain
- 14 dB Nominal Return Loss
- 0.25-um pHEMT 3MI Technology
- 10 lead flange package
- Bias Conditions: 8 V @ 2.6 A Idq
- Package dimension: 0.45 x 0.68 x 0.12 in.

### **Primary Applications**

- Ku band VSAT Transmitter
- Point to Point Radio

#### Measured Data



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Note: Devices designated as EPU are typically early in their characterization process prior to finalizing all electrical and process specifications. Specifications are subject to change without notice.



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#### TABLE I MAXIMUM RATINGS

Symbol	Parameter <u>1/</u>	Value	Notes
V <sup>+</sup>	Positive Supply Voltage	9 V	<u>2/</u>
V	Negative Supply Voltage Range	-5V TO -0.35V	
I <sup>+</sup>	Positive Supply Current	4 A	<u>2/</u>
I <sub>G</sub>	Gate Supply Current	113 mA	
P <sub>IN</sub>	Input Continuous Wave Power	30.3 dBm	<u>2</u> /
P <sub>D</sub>	Power Dissipation	20.8 W	<u>2</u> /, <u>3/</u>
T <sub>CH</sub>	Operating Channel Temperature	150 <sup>0</sup> C	<u>4</u> /
Τ <sub>M</sub>	Mounting Temperature (30 Seconds)	210 °C	
T <sub>STG</sub>	Storage Temperature	-65 to 150 <sup>0</sup> C	

- 1/ These ratings represent the maximum operable values for this device.
- $\underline{2}$ / Combinations of supply voltage, supply current, input power, and output power shall not exceed  $P_D$ .
- $\underline{3}$ / When operated at this bias condition with a base plate temperature of 70  $^{0}$ C, the median life is 1E+6 hours.
- <u>4</u>/ Junction operating temperature will directly affect the device median time to failure (T<sub>M</sub>). For maximum life, it is recommended that junction temperatures be maintained at the lowest possible levels.

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#### TABLE II RF CHARACTERIZATION TABLE $(T_A = 25^{\circ}C, Nominal)$ (Vd = 8V, Id = 2.6 A)

SYMBOL	PARAMETER	TEST CONDITION	TYPICAL	UNITS
Gain	Small Signal Gain	f = 13-16 GHz	24	dB
IRL	Input Return Loss	f = 13-16 GHz	14	dB
ORL	Output Return Loss	f = 13-16 GHz	14	dB
Psat	Saturated Power	f = 13-16 GHz	38	dBm

#### TABLE III THERMAL INFORMATION

Parameter	Test Conditions	Т <sub>сн</sub> (°С)	R <sub>θJC</sub> (°C/W)	T <sub>M</sub> (HRS)
R <sub>eJC</sub> Thermal Resistance (channel to backside of	Vd = 8 V I <sub>D</sub> = 2.6 A (Quiescent) Pdiss = 20.8 W	150	3.9	1 E+6
package)				

Note: Package backside SnPb soldered to carrier at 70°C baseplate temperature. At saturated output power, the DC power consumption is 28.8 W with 6.5 W RF power delivered to the load. Power dissipated is 22.3 W and the temperature rise in the channel is 87 °C. The baseplate temperature must be reduced to 63°C to remain below the 150 °C maximum channel temperature.

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# **Evaluation Board Drawing**



Notes:

- 1. Vd must remain below 9V to comply with maximum rating value.
- 2. The drain supply must be connected to both sides of the evaluation block.
- 3. The cooling fan must be powered at all times when the device is under bias.
- 4. Connect fan supply red/black to +12V. It requires ~100mA.

# GaAs MMIC devices are susceptible to damage from Electrostatic Discharge. Proper precautions should be observed during handling, assembly and test.

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## **Assembly Diagram**



Note: Vg can be biased from either Pin 1 or Pin 5

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## Mechanical Drawing TGA2514-EPU-FL

Note: All dimensions are in inches with ±0.005 tolerance

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### Assembly of a TGA2514-EPU-FL Surface Mount Package onto a Motherboard

- 1. Clean the motherboard or module with acetone. Rinse with alcohol and DI water. Allow the circuit to fully dry.
- 2. To improve the thermal and RF performance, we recommend a heat sink attached to the bottom of the package and apply SnPb or equivalent solder to the bottom of TGA2514.
- 3. Apply SnPb or equivalent solder to each pin of TGA2514 and to the backside of the package.
- 4 Clean the assembly with alcohol.

#### **Ordering Information**

Part	Package Style
TGA2514-EPU-FL	Flange (package bolted down)

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